

SiC JFET Division

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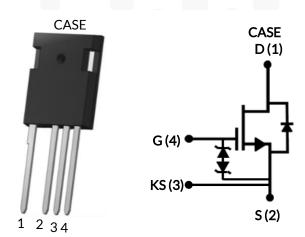








UJ4C075033K4S



| Part Number | Package | Marking | | |
|---------------|-----------|---------------|--|--|
| UJ4C075033K4S | TO-247-4L | UJ4C075033K4S | | |







Silicon Carbide (SiC) Cascode JFET -EliteSiC, Power N-Channel, TO-247-4L, 750 V, 33 mohm

Rev. C, January 2025

Description

The UJ4C075033K4S is a 750V, $33m\Omega$ G4 SiC FET. It is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the TO-247-4L package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads and any application requiring standard gate drive.

Features

- On-resistance $R_{DS(on)}$: $33m\Omega$ (typ)
- Operating temperature: 175°C (max)
- Excellent reverse recovery: Q_{rr} = 88nC
- Low body diode V_{FSD}: 1.26V
- ◆ Low gate charge: Q_G = 37.8nC
- Threshold voltage V_{G(th)}: 4.8V (typ) allowing 0 to 15V drive
- Low intrinsic capacitance
- ESD protected: HBM class 2 and CDM class C3
- TO-247-4L package for faster switching, clean gate waveforms
- AECQ Qualified

Typical applications

- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating













Maximum Ratings

| Parameter | Symbol | Test Conditions | Value | Units |
|---|------------------|-------------------------------|------------|-------|
| Drain-source voltage | V_{DS} | | 750 | V |
| Cata aguiras valtaga | V | DC | -20 to +20 | V |
| Gate-source voltage | V_{GS} | AC (f > 1Hz) | -25 to +25 | V |
| Continuous durin numeral 1 | 1 | T _C = 25°C | 47 | А |
| Continuous drain current ¹ | I _D | T _C =100°C | 35 | Α |
| Pulsed drain current ² | I _{DM} | T _C = 25°C | 140 | Α |
| Single pulsed avalanche energy ³ | E _{AS} | L=15mH, I _{AS} =2.4A | 43 | mJ |
| SiC FET dv/dt ruggedness | dv/dt | $V_{DS} \le 500V$ | 200 | V/ns |
| Power dissipation | P _{tot} | T _C = 25°C | 242 | W |
| Maximum junction temperature | $T_{J,max}$ | | 175 | °C |
| Operating and storage temperature | T_J, T_{STG} | | -55 to 175 | °C |
| Max. lead temperature for soldering, 1/8" from case for 5 seconds | T _L | | 250 | °C |

- 1. Limited by $T_{J,max}$
- 2. Pulse width t_p limited by $T_{J,max}$
- 3. Starting $T_J = 25^{\circ}C$

Thermal Characteristics

| Darameter | Symbol | Test Conditions | Value | | | Units |
|--------------------------------------|-----------------|-----------------|-------|------|------|-------|
| Parameter | | | Min | Тур | Max | Units |
| Thermal resistance, junction-to-case | $R_{\theta JC}$ | | | 0.48 | 0.62 | °C/W |

Rev. C, January 2025















Electrical Characteristics (T_J = +25°C unless otherwise specified)

Typical Performance - Static

| Parameter | Symbol | Test Conditions | Value | | | Units |
|--------------------------------|---------------------|--|-------|-----|-----|-------|
| i ai airictei | | | Min | Тур | Max | Units |
| Drain-source breakdown voltage | BV_{DS} | V_{GS} =0V, I_D =1mA | 750 | | | V |
| Total drain leakage current | | V _{DS} =750V, V _{GS} =0V, T _J =25°C | | 2 | 20 | μΑ |
| | I _{DSS} | V _{DS} =750V, V _{GS} =0V, T _J =175°C | | 20 | | |
| Total gate leakage current | I _{GSS} | V _{DS} =0V, T _J =25°C, V _{GS} =-20V / +20V | | 6 | ±20 | μА |
| Drain-source on-resistance | R _{DS(on)} | V_{GS} =12V, I_{D} =30A, T_{J} =25°C | | 33 | 41 | |
| | | V _{GS} =12V, I _D =30A, T _J =125°C | | 57 | | mΩ |
| | | V _{GS} =12V, I _D =30A, T _J =175°C | | 75 | | |
| Gate threshold voltage | $V_{G(th)}$ | V_{DS} =5V, I_{D} =10mA | 4 | 4.8 | 6 | V |
| Gate resistance | R_{G} | f=1MHz, open drain | | 4.5 | | Ω |

Typical Performance - Reverse Diode

| Parameter | Symbol | Test Conditions | Value | | | Units |
|---|----------------------|--|-------|------|------|--------|
| Parameter | Зуппон | | Min | Тур | Max | Offics |
| Diode continuous forward current ¹ | I _S | T _C = 25°C | | | 47 | Α |
| Diode pulse current ² | I _{S,pulse} | T _C = 25°C | | | 140 | А |
| Forward voltage | V_{FSD} | V _{GS} =0V, I _S =15A, T _J =25°C | | 1.26 | 1.42 | V |
| | | V _{GS} =0V, I _S =15A, T _J =175°C | | 1.59 | | |
| Reverse recovery charge | Q _{rr} | V_R =400V, I_S =30A, V_{GS} =0V, R_{G_EXT} =5 Ω | | 88 | | nC |
| Reverse recovery time | t _{rr} | di/dt=3100A/μs, Τ _J =25°C | | 11.5 | | ns |
| Reverse recovery charge | Q _{rr} | V_R =400V, I_S =30A, V_{GS} =0V, R_{G_EXT} =5 Ω | | 95 | | nC |
| Reverse recovery time | t _{rr} | di/dt=3100A/μs, Τ _J =150°C | | 12 | | ns |















Typical Performance - Dynamic

| Davisantan | Comple a l | Took Com distings | Value | | | 11.20 |
|---|----------------------|---|-------|------|-----|-----------|
| Parameter | Symbol | Test Conditions | Min | Тур | Max | Units |
| Input capacitance | C _{iss} | V _{DS} =400V, V _{GS} =0V — f=100kHz | | 1400 | | |
| Output capacitance | C _{oss} | | | 68 | | pF |
| Reverse transfer capacitance | C _{rss} | 1-100KH2 | | 2.5 | | |
| Effective output capacitance, energy related | C _{oss(er)} | V _{DS} =0V to 400V, V _{GS} =0V | | 83 | | pF |
| Effective output capacitance, time related | C _{oss(tr)} | V_{DS} =0V to 400V, V_{GS} =0V | | 162 | | pF |
| C _{OSS} stored energy | E _{oss} | V _{DS} =400V, V _{GS} =0V | | 6.6 | | μЈ |
| Total gate charge | Q_{G} | V_{DS} =400V, I_{D} =30A, V_{GS} = 0V to 15V | | 37.8 | | |
| Gate-drain charge | Q_{GD} | | | 8 | | nC |
| Gate-source charge | Q_{GS} | | | 11.8 | | 1 |
| Turn-on delay time | t _{d(on)} | Notes 4 and 5, V _{DS} =400V, I _D =30A, Gate Driver =0V to +15V, | | 12 | | - - ns |
| Rise time | t _r | | | 19 | | |
| Turn-off delay time | t _{d(off)} | | | 18 | | |
| Fall time | t _f | Turn-on $R_{G,EXT}$ =1 Ω , Turn-off $R_{G,EXT}$ =5 Ω , | | 7 | | |
| Turn-on energy including R _S energy | E _{ON} | inductive Load, | | 131 | | μ |
| Turn-off energy including R _S energy | E _{OFF} | FWD: same device with $V_{GS} = 0V$ and $R_G = 5\Omega$, | | 24 | | |
| Total switching energy | E _{TOTAL} | RC snubber: R_S =15 Ω and | | 155 | | |
| Snubber R _S energy during turn-on | E _{RS_ON} | C _S =100pF, | | 3.2 | | |
| Snubber R _S energy during turn-off | E _{RS_OFF} | T _J =25°C | | 10 | | |
| Turn-on delay time | t _{d(on)} | Notes 4 and 5, | | 13 | | |
| Rise time | t _r | V_{DS} =400V, I_D =30A, Gate | | 21 | | |
| Turn-off delay time | t _{d(off)} | Driver =0V to +15V, Turn-on $R_{G,EXT}$ = 1Ω , Turn-off $R_{G,EXT}$ = 5Ω , inductive Load, FWD: same device with V_{GS} = 0V and R_{G} = 5Ω , RC snubber: R_{S} =15 Ω and | | 20 | | ns |
| Fall time | t _f | | | 9 | | |
| Turn-on energy including R _S energy | E _{ON} | | | 160 | | |
| Turn-off energy including R _S energy | E _{OFF} | | | 41 | | |
| Total switching energy | E _{TOTAL} | | | 201 | | μJ |
| Snubber R _S energy during turn-on | E _{RS_ON} | C _S =100pF, | | 3 | | |
| Snubber R _S energy during turn-off | E _{RS_OFF} | T _J =150°C | | 9.6 | | |

^{4.} Measured with the switching test circuit in Figure 35.

^{5.} In this datasheet, all the switching energies (turn-on energy, turn-off energy and total energy) presented in the tables and Figures include the device RC snubber energy losses.















| Devenuetes | Cymbol | Test Conditions | Value | | | Units |
|---|---------------------|---|-------|------|-----|-------|
| Parameter | Symbol | | Min | Тур | Max | Units |
| Turn-on delay time | t _{d(on)} | | | 11.5 | | |
| Rise time | t _r | Note 6, V _{DS} =400V, I _D =30A, Gate | | 19 | | |
| Turn-off delay time | t _{d(off)} | V_{DS} 200 V, I_D 200A, Gate Driver = 0V to +15V, | | 17.5 | | ns |
| Fall time | t _f | Turn-on $R_{G,EXT}=1\Omega$, | | 6 | | |
| Turn-on energy including R _S energy | E _{ON} | Turn-off $R_{G,EXT} = 5\Omega$, inductive Load, | | 114 | | |
| Turn-off energy including R _S energy | E _{OFF} | FWD: UJ3D06520TS, | | 22 | | |
| Total switching energy | E _{TOTAL} | RC snubber: R_S =15 Ω and C_S =100pF, T_J =25°C | | 136 | | μЈ |
| Snubber R _S energy during turn-on | E _{RS_ON} | | | 4.1 | | |
| Snubber R _S energy during turn-off | E _{RS_OFF} | | | 14 | | |
| Turn-on delay time | t _{d(on)} | | | 13 | | |
| Rise time | t _r | Note 6, V _{DS} =400V, I _D =30A, Gate | | 16 | | nc |
| Turn-off delay time | t _{d(off)} | v_{DS} =400 v, v_D =30A, Gate Driver =0V to +15V, | | 23 | | ns |
| Fall time | t _f | Turn-on $R_{G,EXT}$ =1 Ω , Turn- | | 7 | | |
| Turn-on energy including R _S energy | E _{ON} | off $R_{G,EXT} = 5\Omega$, inductive Load, | | 137 | | |
| Turn-off energy including R _S energy | E _{OFF} | FWD: UJ3D06520TS, RC snubber: R_s =15 Ω and C_s =100pF, T_J =150°C | | 39 | | |
| Total switching energy | E _{TOTAL} | | | 176 | | μЈ |
| Snubber R _S energy during turn-on | E _{RS_ON} | | | 4 | | |
| Snubber R _S energy during turn-off | E _{RS_OFF} | | | 14 | | |

^{6.} Measured with the switching test circuit in Figure 36.





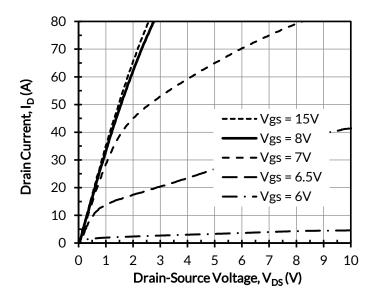








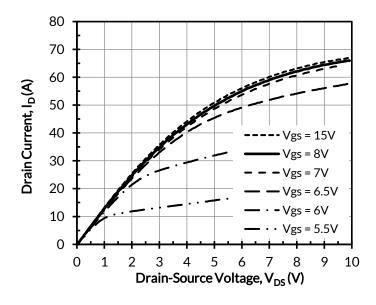




80 70 60 Drain Current, I_D (A) 50 40 Vgs = 15V30 Vgs = 8V Vgs = 7V20 - Vgs = 6.5V 10 Vgs = 6V 0 0 1 2 3 5 10 Drain-Source Voltage, V_{DS} (V)

Figure 1. Typical output characteristics at T_J = - 55°C, tp < 250 μ s

Figure 2. Typical output characteristics at $T_J = 25$ °C, $tp < 250\mu s$



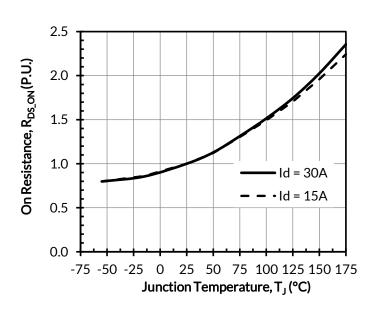


Figure 3. Typical output characteristics at T_J = 175°C, tp < 250 μ s

Figure 4. Normalized on-resistance vs. temperature at V_{GS} = 12V





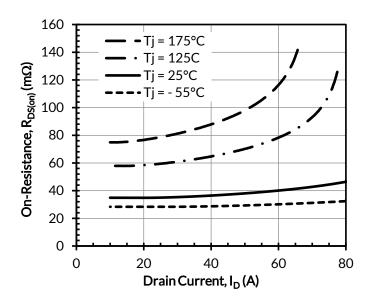








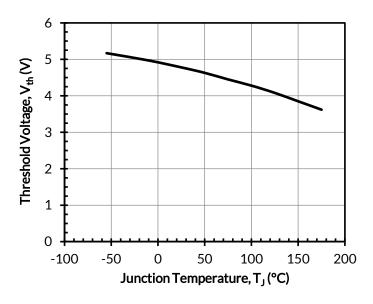




60 Tj = -55°C 50 Tj = 25°C Drain Current, I_D (A) Tj = 175°C 40 30 20 10 0 5 8 9 0 1 2 3 4 6 10 Gate-Source Voltage, $V_{GS}(V)$

Figure 5. Typical drain-source on-resistances at V_{GS} = 12V

Figure 6. Typical transfer characteristics at $V_{DS} = 5V$



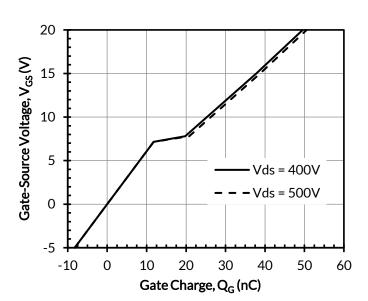


Figure 7. Threshold voltage vs. junction temperature at V_{DS} = 5V and I_D = 10mA

Figure 8. Typical gate charge at $I_D = 30A$















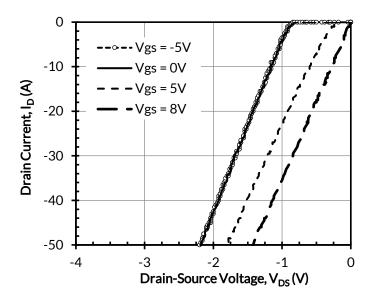


Figure 9. 3rd quadrant characteristics at $T_J = -55$ °C

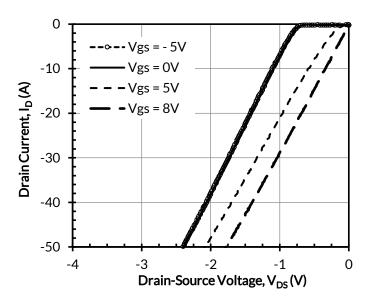


Figure 10. 3rd quadrant characteristics at T_J = 25°C

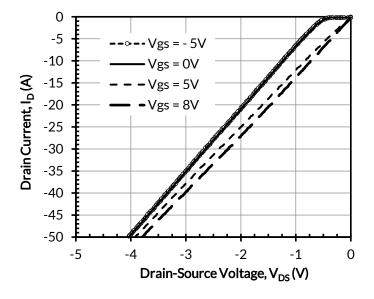


Figure 11. 3rd quadrant characteristics at $T_J = 175$ °C

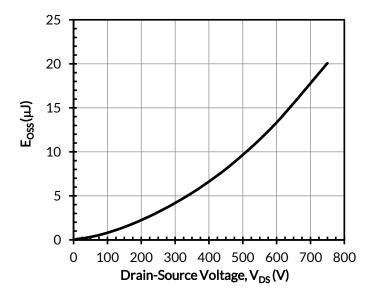


Figure 12. Typical stored energy in C_{OSS} at $V_{GS} = 0V$



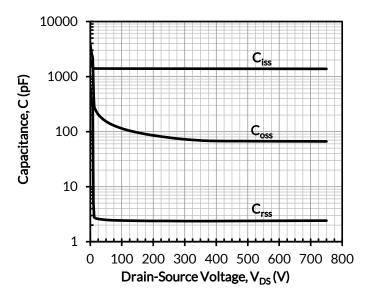








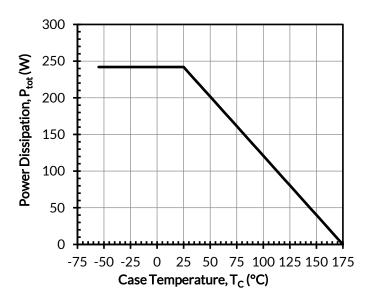




50 40 40 30 10 -75 -50 -25 0 25 50 75 100 125 150 175 Case Temperature, T_c (°C)

Figure 13. Typical capacitances at f = 100kHz and $V_{GS} = 0V$

Figure 14. DC drain current derating



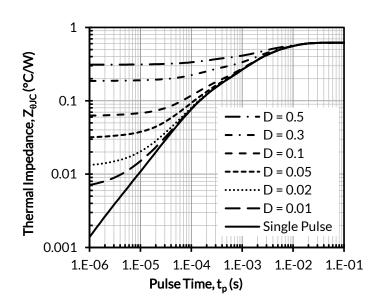


Figure 15. Total power dissipation

Figure 16. Maximum transient thermal impedance













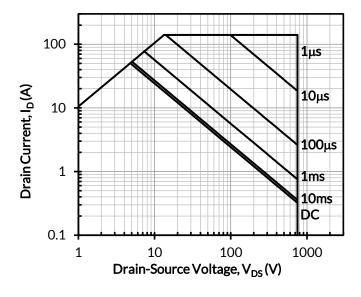


Figure 17. Safe operation area at T_C = 25°C, D = 0, Parameter t_p

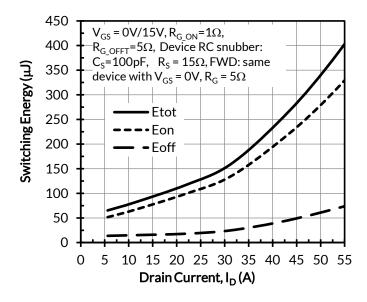


Figure 19. Clamped inductive switching energy vs. drain current at V_{DS} = 400V and T_J = 25°C

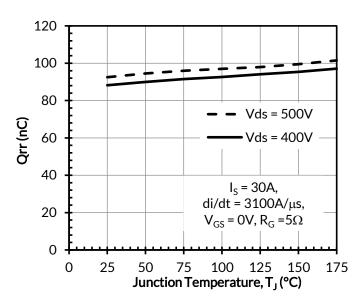


Figure 18. Reverse recovery charge Qrr vs. junction temperature

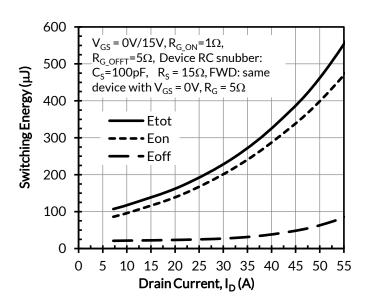


Figure 20. Clamped inductive switching energy vs. drain current at $V_{DS} = 500V$ and $T_J = 25^{\circ}C$



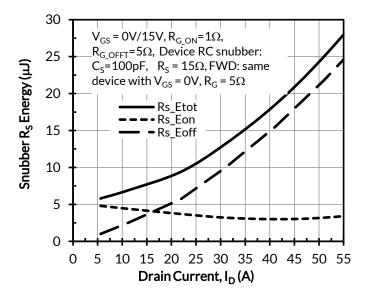








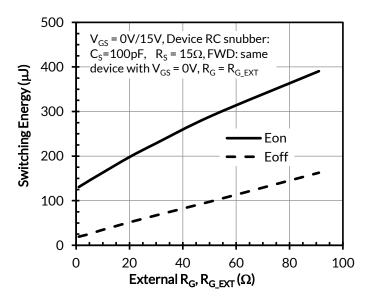




30 $V_{GS} = 0V/15V, R_{G_ON} = 1\Omega, R_{G_OFFT} = 5\Omega,$ Device RC snubber: $C_s = 100 \text{pF}$, $R_s = 15\Omega$, 25 FWD: same device with $V_{GS} = 0V$, $R_G = 5\Omega$ Snubber R_S Energy (µJ) Rs_Etot 20 • • Rs_Eon - Rs_Eoff 15 10 5 0 0 5 10 15 20 25 30 35 40 45 50 55 Drain Current, ID (A)

Figure 21. RC snubber energy loss vs. drain current at $V_{DS} = 400V$ and $T_J = 25^{\circ}C$

Figure 22. RC snubber energy losses vs. drain current at $V_{DS} = 500V$ and $T_J = 25^{\circ}C$



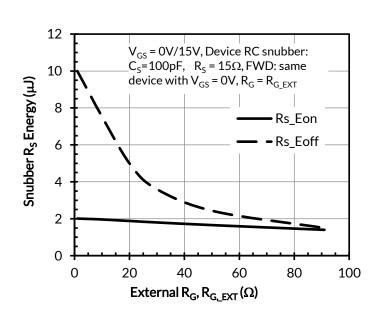


Figure 23. Clamped inductive switching energies vs. $R_{G,EXT}$ at V_{DS} = 400V, I_D = 30A, and T_J = 25°C

Figure 24. RC snubber energy losses vs. $R_{G,EXT}$ at V_{DS} = 400V, I_D = 30A, and T_J = 25°C





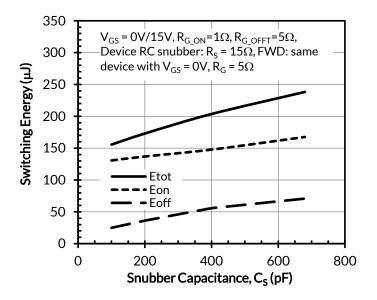








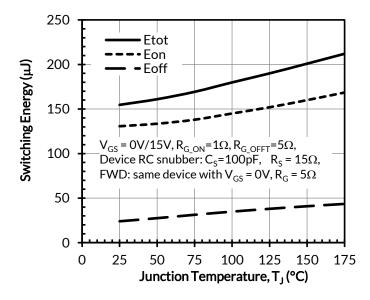




80 $V_{GS} = 0V/15V, R_{G_{-}ON} = 1\Omega,$ 70 $R_{G OFFT} = 5\Omega$, Device RC snubber: $R_S = 15\Omega$, FWD: Snubber R_s Energy (μJ) 60 same device with $V_{GS} = 0V$, $R_G = 5\Omega$ 50 40 30 20 Rs_Etot 10 Rs Eon Rs_Eoff 0 0 200 400 600 800 Snubber Capacitance, C_S (pF)

Figure 25. Clamped inductive switching energies vs. snubber capacitance C_S at V_{DS} = 400V, I_D = 30A, and T_1 = 25°C

Figure 26. RC snubber energy losses vs. snubber capacitance C_S at V_{DS} = 400V, I_D = 30A, and T_J = 25°C



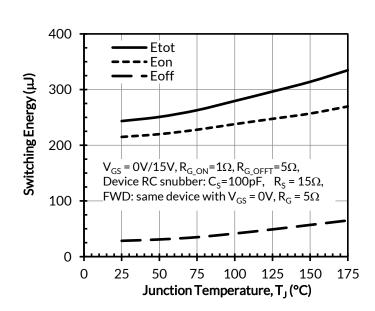


Figure 27. Clamped inductive switching energy vs. junction temperature at V_{DS} =400V and I_{D} = 30A

Figure 28. Clamped inductive switching energy vs. junction temperature at V_{DS} = 500V and I_D = 30A













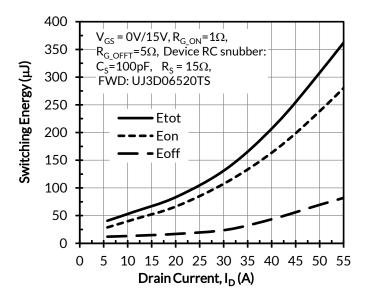


Figure 29. Clamped inductive switching energy vs. drain current at $V_{DS} = 400V$ and $T_J = 25^{\circ}C$

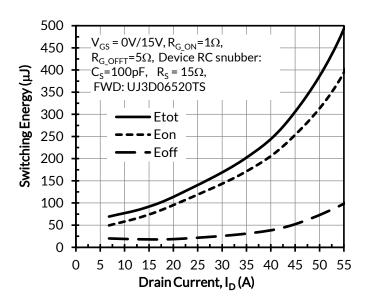


Figure 30. Clamped inductive switching energy vs. drain current at $V_{DS} = 500V$ and $T_J = 25^{\circ}C$

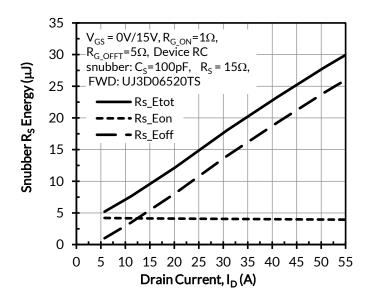


Figure 31. RC snubber energy losses vs. drain current at V_{DS} = 400V and T_J = 25°C

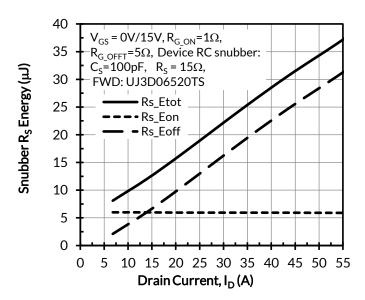


Figure 32. RC snubber energy losses vs. drain current at V_{DS} = 500V and T_J = 25°C





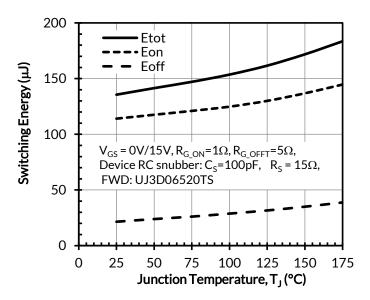








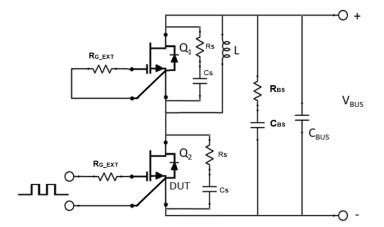




350 Etot 300 **Eoff** Switching Energy (μJ) 250 200 150
$$\begin{split} V_{GS} = 0 V/15 V, R_{G_ON} = 1 \Omega, R_{G_OFFT} = 5 \Omega, \\ \text{Device RC snubber: } C_S = 100 \text{pF}, \quad R_S = 15 \Omega, \end{split}$$
100 FWD: UJ3D06520TS 50 0 0 25 75 100 125 150 Junction Temperature, T₁ (°C)

Figure 33. Clamped inductive switching energy vs. junction temperature at V_{DS} =400V and I_D = 30A

Figure 34. Clamped inductive switching energy vs. junction temperature at V_{DS} = 500V and I_D = 30A



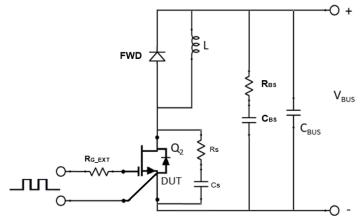


Figure 35. Schematic of the half-bridge mode switching test circuit. Note, a bus RC snubber (R_{BS} = 2.5Ω , C_{BS} =100nF) is used to reduce the power loop high frequency oscillations.

Figure 36. Schematic of the chopper mode switching test circuit. Note, a bus RC snubber (R_{BS} = 2.5 Ω , C_{BS}=100nF) is used to reduce the power loop high frequency oscillations.













Applications Information

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{DS(on)}$), output capacitance (C_{oss}), gate charge (Q_G), and reverse recovery charge (Q_{rr}) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com.

A snubber circuit with a small $R_{(G)}$, or gate resistor, provides better EMI suppression with higher efficiency compared to using a high $R_{(G)}$ value. There is no extra gate delay time when using the snubber circuitry, and a small $R_{(G)}$ will better control both the turn-off $V_{(DS)}$ peak spike and ringing duration, while a high $R_{(G)}$ will damp the peak spike but result in a longer delay time. In addition, the total switching loss when using a snubber circuit is less than using high $R_{(G)}$, while greatly reducing $E_{(OFF)}$ from mid-to-full load range with only a small increase in $E_{(ON)}$. Efficiency will therefore improve with higher load current. For more information on how a snubber circuit will improve overall system performance, visit the UnitedSiC website at www.unitedsic.com

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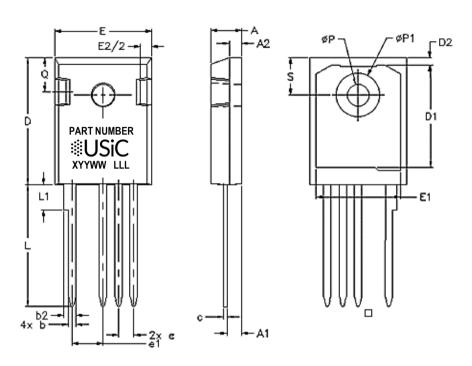
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Datasheet: UJ4C075033K4S Rev. C, January 2025



TO-247-4L PACKAGE OUTLINE, PART MARKING AND TUBE SPECIFICATIONS

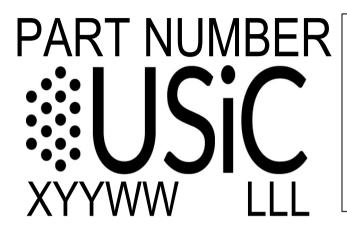
PACKAGE OUTLINE



| DIM | INC | HES | MILLIMETERS | | |
|-----|-----------|-------|-------------|-------|--|
| | MIN | MAX | MIN | MAX | |
| Α | 0.185 | 0.209 | 4.7 | 5.31 | |
| A1 | 0.087 | 0.102 | 2.21 | 2.59 | |
| A2 | 0.059 | 0.098 | 1.5 | 2.49 | |
| b | 0.039 | 0.055 | 0.99 | 1.4 | |
| b2 | 0.065 | 0.094 | 1.65 | 2.39 | |
| С | 0.015 | 0.035 | 0.38 | 0.89 | |
| D | 0.819 | 0.845 | 20.8 | 21.46 | |
| D1 | 0.515 | - | 13.08 | - | |
| D2 | 0.02 | 0.053 | 0.51 | 1.35 | |
| E | 0.61 | 0.64 | 15.49 | 16.26 | |
| е | 0.100 BSC | | 2.54 BSC | | |
| e1 | 0.19 | 0.21 | 4.83 | 5.33 | |
| E1 | 0.53 | - | 13.46 | - | |
| E2 | 0.14 | 0.16 | 3.56 | 4.06 | |
| L | 0.78 | 0.8 | 19.81 | 20.32 | |
| L1 | - | 0.177 | | 4.5 | |
| ФР | 0.14 | 0.144 | 3.56 | 3.66 | |
| ФР1 | 0.278 | 0.291 | 7.06 | 7.39 | |
| Q | 0.212 | 0.244 | 5.38 | 6.2 | |
| S | 0.243 BSC | | 6.17 BSC | | |



TO-247-4L PACKAGE OUTLINE, PART MARKING AND TUBE SPECIFICATIONS



PART NUMBER = REFER TO
DS PN DECODER FOR DETAILS

X = ASSEMBLY SITE

YY = YEAR

WW = WORK WFFK

LLL = LOT ID

PACKING TYPE

ANTI-STATIC TUBE

QUANTITY /TUBE: 30 UNITS

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